

<b>Notice of References Cited</b>	Application/Control No. 10/761,303		Applicant(s)/Patent Under Reexamination YAMADA, KOHEI	
	Examiner D. Rutledge		Art Unit 2851	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,740,052	04-1998	Nakamura, Gen	414/940
*	B	US-6,414,744	07-2002	Kuiper et al.	355/75
*	C	US-6,826,451	11-2004	del Puerto et al.	700/245
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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**NON-PATENT DOCUMENTS**

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